## Notice of References Cited Application/Control No. 10/658,912 Examiner PHILIP J. CHEA Applicant(s)/Patent Under Reexamination IYER ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,282,568 B1	08-2001	Sondur et al.	709/223
*	В	US-6,321,249 B1	11-2001	Nesbitt, David P.	709/202
*	С	US-2002/0035621 A1	03-2002	Zintel et al.	709/220
*	D	US-6,581,094 B1	06-2003	Gao, Jici	709/220
*	Е	US-2003/0204578 A1	10-2003	Yip et al.	709/222
*	F	US-7,017,148 B2	03-2006	Kumar, Murari	717/114
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

	NON-I ATENT BOODMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.